## Notice of References Cited Application/Control No. 10/664,770 Applicant(s)/Patent Under Reexamination HAYASAKA, SATOSHI Examiner Paul Ip 2837 Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0100440	05-2004	Levin et al.	345/156
*	В	US-2004/0032395	02-2004	Goldenberg et al.	345/156
*	С	US-6,686,911	02-2004	Levin et al.	345/184
*	D	US-6,636,197	10-2003	Goldenberg et al.	345/156
*	Е	US-6,154,201	11-2000	Levin et al.	345/184
*	F	US-5,944,151	08-1999	Jakobs et al.	188/267.1
*	G	US-5,381,080	01-1995	Schnell et al.	318/566
*	Н	US-5,220,260	06-1993	Schuler, Chester L.	318/561
*	1	US-4,402,246	09-1983	Sekiguchi, Tomoaki	84/622
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
	0					
	Р					
	Q					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

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